



MJ N-Channel Enhancement Mode Power MOSFET

Description

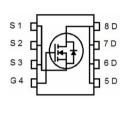
The MJ3075Q uses advanced trench technology and design to provide excellent $R_{\text{DS}(\text{ON})}$ with low gate charge. It can be used in a wide variety of applications.

General Features

- $ightharpoonup V_{DS}=30V,I_D=75A$ $R_{DS(ON)}<2.9m\Omega$ (typical) @ V_{GS}=10V $R_{DS(ON)}<4.1m\Omega$ (typical) @ V_{GS}=4.5V
- ◆ High density cell design for ultra low Rdson
- ♦ Very low on-resistance R_{DS(on)}
- ◆ Good stability and uniformity with high EAS
- ◆ 150 °C operating temperature
- ◆ Pb-free lead plating

Application

- ◆ DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification







Top View

Bottom View

100% UIS TESTED! 100% ΔVds TESTED!

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|---------|----------------|-----------|------------|----------|
| MJ3075Q | MJ3075Q | DFN 3.3x3.3-8L | - | - | - |

Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|-----------|------------|------|
| Drain-Source Voltage | VDS | 30 | V |
| Gate-Source Voltage | Vgs | ±20 | V |
| Drain Current-Continuous (Note 1) | lo | 75 | А |
| Drain Current-Continuous(Tc =100°C) | ID(100°C) | 53 | А |
| Pulsed Drain Current | Ірм | 300 | А |
| Maximum Power Dissipation | Po | 50 | W |
| Single pulse avalanche energy (Note 5) | Eas | 150 | mJ |
| Derating factor | | 0.4 | W/°C |
| Operating Junction and Storage Temperature Range | Тл ,Тѕтс | -55 To 150 | °C |

Thermal Characteristic

| Thermal Resistance, Junction-to-Case (Note 2) | RөJA | 2.5 | °C/W |
|---|------|-----|------|
|---|------|-----|------|





Electrical Characteristics (T_A =25°Cunless otherwise noted)

| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|------------------------------------|---------------------|--|-----|------|------|----------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BVDSS | V _{GS} =0V I _D =250µA | 30 | - | - | V |
| Zero Gate Voltage Drain Current | IDSS | Vps=30V,Vgs=0V | - | - | 1 | μΑ |
| Gate-Body Leakage Current | lgss | V _{DS} =±20V,V _{DS} =0V | _ | _ | ±100 | nA |
| On Characteristics (Note 3) | | | | | | |
| Gate Threshold Voltage | VGS(th) | V _{DS} =V _{GS} ,I _D =250µA | 1 | 1.5 | 2.2 | V |
| Drain-Source On-State Resistance | RDS(ON) | V _{GS} =10V, I _D =20A | - | 2.9 | 3.5 | mΩ |
| Brain course on state resistance | TADS(ON) | V _{GS} =4.5V, I _D =20A | - | 4.1 | 7.0 | mΩ |
| Forward Transconductance | grs | V _{DS} =5V,I _D =20A | 30 | - | - | S |
| Dynamic Characteristics (Note 4) | - | | | | | |
| Input Capacitance | Clss | V _{DS} =15V,V _{GS} =0V, F=1.0MHz | - | 1784 | - | PF |
| Output Capacitance | Coss | | - | 266 | - | PF |
| Reverse Transfer Capacitance | Crss | | - | 212 | - | PF |
| Switching Characteristics (Note 4) | · | | | | | |
| Turn-on Delay Time | t _{d(on)} | | - | 7 | - | nS |
| Turn-on Rise Time | tr | V _{DD} =5V,I _D =20A | - | 6 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | Vgs=10V,Rgen=6Ω | - | 30 | - | nS |
| Turn-Off Fall Time | tr | | - | 8 | - | nS |
| Total Gate Charge | Qg | | - | 38.4 | - | nC |
| Gate-Source Charge | Qgs | V _{DS} =15V,I _D =20A, V _{GS} =10V | - | 5.8 | - | nC |
| Gate-Drain Charge | Qgd | | - | 7.9 | - | nC |
| Drain-Source Diode Characteristics | | | | l | | <u> </u> |
| Diode Forward Voltage (Note 3) | VsD | V _{GS} =0V,I _S =20A | - | 0.85 | 1.2 | V |
| Diode Forward Current (Note 2) | ls | | - | - | 75 | А |
| Reverse Recovery Time | trr | TJ=25°C, IF=20A | - | _ | 47 | nS |
| Reverse Recovery Charge | Qrr | di/dt=100A/µs (Note 3) | _ | _ | 25 | nC |
| Forward Turn-On Time | ton | Intrinsic turn-on time is negligible(turn-on is dominated by LS+LI | | | | y LS+LD) |

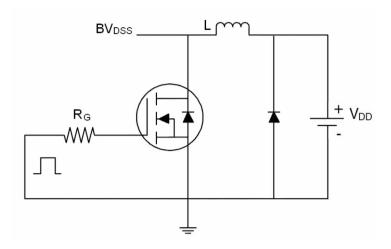
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3 Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- \bigcirc EAS condition: Tj=25°C,VDD=15V,VG=10V,L=0.5mH,Rg=25 Ω

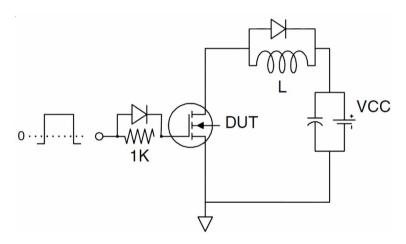




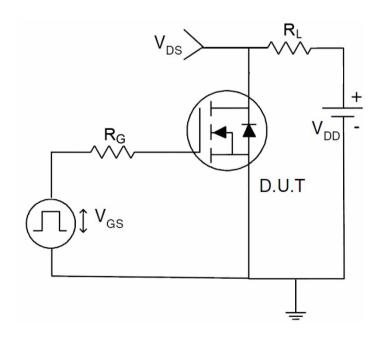
Test circuit



Eas test Circuit



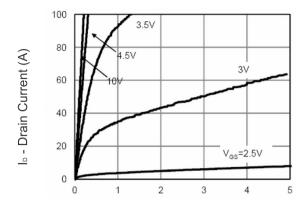
Gate charge test Circuit



Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics

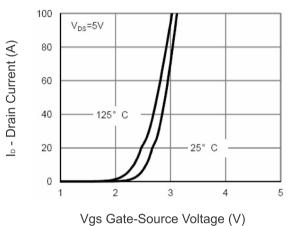


Figure 2 Transfer Characteristics

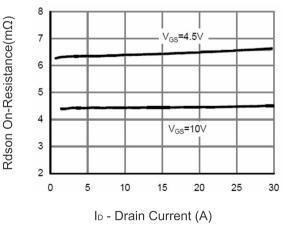
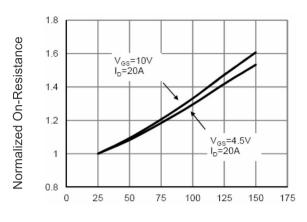


Figure 3 Rdson- Drain Current



T_J -Junction Temperature(°C)

Figure 4 Rdson-Junction Temperature

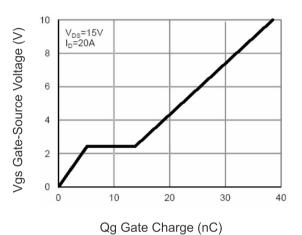


Figure 5 Gate Charge

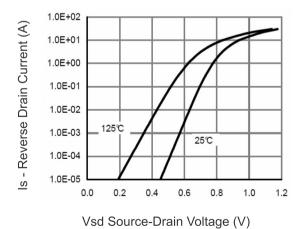
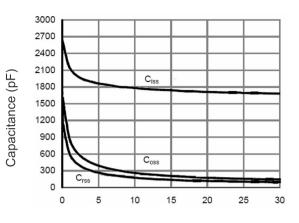
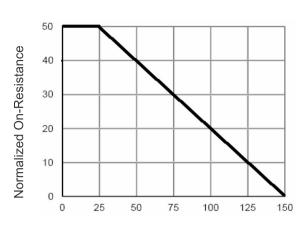


Figure 6 Source- Drain Diode Forward





Vds Drain-Source Voltage (V) Figure 7 Capacitance vs Vds



T_J -Junction Temperature(°C) Figure 9 Power De-rating

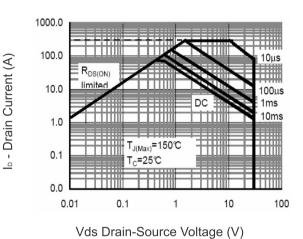
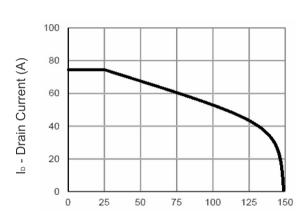


Figure 8 Safe Operation Area



T_J -Junction Temperature(°C) Figure 10 Current De-rating

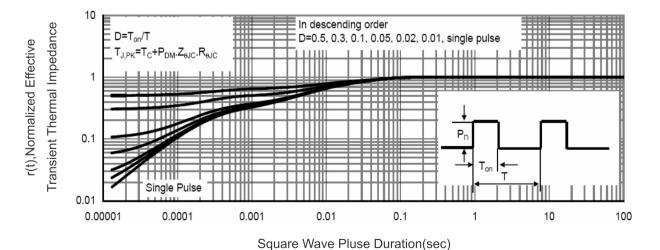
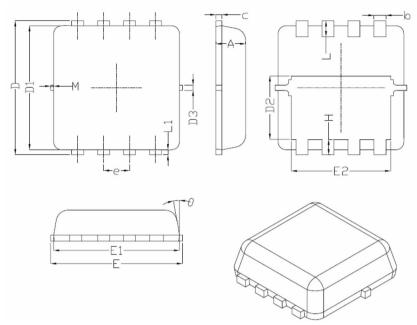


Figure 11 Normalized Maximum Transient Thermal Impedance





DFN3.3X3.3-8L Package Information



| Complete I | Dimensions In Millimeters | | | |
|------------|---------------------------|-----------------|-----------------|--|
| Symbol | Min. | Nom. | Max. | |
| A | 0.70 | 0.75 | 0.80 | |
| b | 0.25 | 0.30 | 0.35 | |
| С | 0.10 | 0.15 | 0.25 | |
| D | 3.25 | 3.35 | 3.45 | |
| D1 | 3.00 | 3.10 | 3.20 | |
| D2 | 1.48 | 1.58 | 1.68 | |
| D3 | - | 0.13 | - | |
| E | 3.20 | 3.30 | 3.40 | |
| E1 | 3.00 | 3.15 | 3.20 | |
| E2 | 2.39 | 2.49 | 2.59 | |
| е | 0.65BSC | | | |
| Н | 0.30 | 0.39 | 0.50 | |
| L | 0.30 | 0.40 | 0.50 | |
| L1 | - | 0.13 | - | |
| M | * | * | 0.15 | |
| θ | | 10 [°] | 12 [°] | |





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